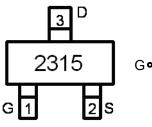


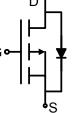
#### Main Product Characteristics:

V <sub>DSS</sub>	-20V	
R <sub>DS</sub> (on)	95mΩ (typ.)	
Ι <sub>D</sub>	-3A	



SOT-23





Marking and pin Schematic diagram Assignment

#### Features and Benefits:

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 150°C operating temperature



#### **Description:**

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

## **Absolute max Rating:**

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ TC = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V①	-3	
I <sub>D</sub> @ TC = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V①	-2.4	A
I <sub>DM</sub>	M Pulsed Drain Current②		
	Power Dissipation3	1.4	W
P <sub>D</sub> @TC = 25°C	Linear Derating Factor	0.011	W/°C
V <sub>DS</sub>	Drain-Source Voltage	-20	V
V <sub>GS</sub>	Gate-to-Source Voltage	± 12	V
T <sub>J</sub> T <sub>STG</sub>	Operating Junction and Storage Temperature Range	-55 to +150	°C

### **Thermal Resistance**

Symbol	Characterizes	Тур.	Max.	Units
Reja	Junction-to-ambient (t $\leq$ 10s) ④	80	100	°C/W



Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source breakdown voltage	-20	_	_	V	V <sub>GS</sub> = 0V, ID = -250µA
		_	95	130		V <sub>GS</sub> =-4.5V,I <sub>D</sub> = -2.8A
RDS(on)	Static Drain-to-Source on-resistance	_	128	160	mΩ	V <sub>GS</sub> =-2.5V,I <sub>D</sub> = -2A
V <sub>GS(th)</sub>	Gate threshold voltage	-0.5	_	-1.0	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$
I <sub>DSS</sub>	Drain-to-Source leakage current	_	_	-1	μA	V <sub>DS</sub> = -20V,V <sub>GS</sub> = 0V
1	Cata to Source forward lookage	_	_	100	<b>n</b> ^	V <sub>GS</sub> =12V
I <sub>GSS</sub>	Gate-to-Source forward leakage	_	_	-100	nA	V <sub>GS</sub> = -12V
Qg	Total gate charge	_	8.5	_		I <sub>D</sub> = -3A,
Q <sub>gs</sub>	Gate-to-Source charge		1.2	_	nC	V <sub>DS</sub> = -10V,
Q <sub>gd</sub>	Gate-to-Drain("Miller") charge		2.1	_		V <sub>GS</sub> = -4.5V
t <sub>d(on)</sub>	Turn-on delay time		7.2	_		
tr	Rise time		36	_		V <sub>GS</sub> =-4.5V, VDS=-10V,
t <sub>d(off)</sub>	Turn-Off delay time	_	53	_	ns	I <sub>D</sub> =-3A ,R <sub>GEN</sub> =3Ω
t <sub>f</sub>	Fall time	_	56	_	]	
Ciss	Input capacitance	_	560	_		V <sub>GS</sub> = 0V
Coss	Output capacitance	_	80	_	pF	V <sub>DS</sub> = -10V
C <sub>rss</sub>	Reverse transfer capacitance	_	70	_	1	f = 1MHz

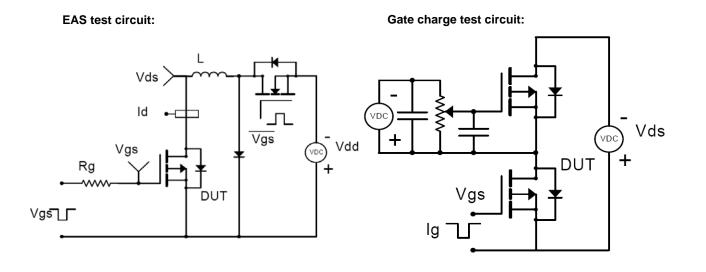
# **Electrical Characterizes** $@T_A=25^{\circ}C$ unless otherwise specified

## **Source-Drain Ratings and Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
	Continuous Source Current		_	-3	А	MOSFET symbol □
Is	(Body Diode)	_				showing the G⊶ H
I <sub>SM</sub>	Pulsed Source Current		_	-15	А	integral reverse
	(Body Diode)	_				p-n junction diode.
V <sub>SD</sub>	Diode Forward Voltage	_	—	-1.2	V	I <sub>S</sub> =-1A, V <sub>GS</sub> =0V
trr	Reverse Recovery Time	_	37		ns	T <sub>J</sub> = 25°C, I <sub>F</sub> =-4A,
Qrr	Reverse Recovery Charge	_	27		nC	di/dt = 100A/µs

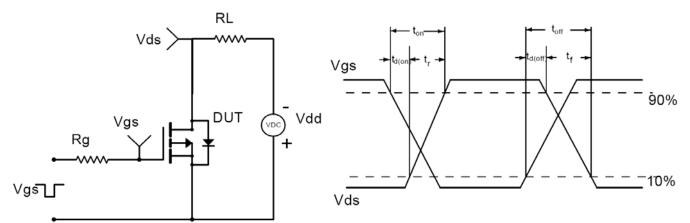


## **Test circuits and Waveforms**



Switching time test circuit:

Switch Waveforms:

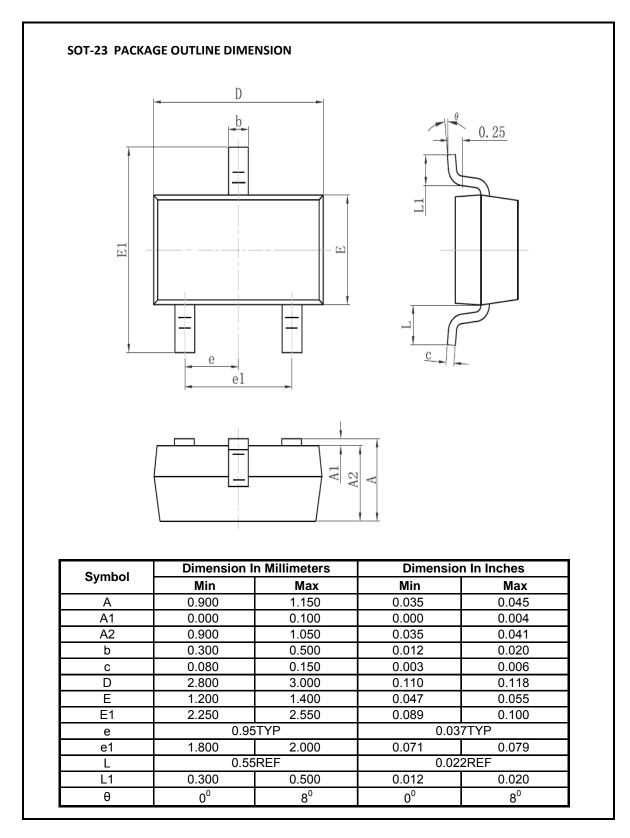


#### Notes:

- ①The maximum current rating is limited by bond-wires.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- (4) The value of  $R_{\theta JA}$  is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C



## **Mechanical Data:**





## **Ordering and Marking Information**

<b>Device Markin</b>	g: 2315	
	Package (Available)	
	SOT-23	
	Operating Temperature Range	
	C : -55 to 150 °C	

## **Devices per Unit**

Package Type	Units/ Tube	Tubes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
SOT-23	3000	10	30000	4	120000

## **Reliability Test Program**

Test Item	Conditions	Duration	Sample Size
High	Tj=150℃ @ 80% of	168 hours	3 lots x 77 devices
Temperature	Max V <sub>DSS</sub> /V <sub>CES</sub> /V <sub>R</sub>	500 hours	
Reverse		1000 hours	
Bias(HTRB)			
High	Tj=150℃@ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V <sub>GSS</sub>	500 hours	
Gate		1000 hours	
Bias(HTGB)			



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